Notice of References Cited Application/Control No. 10/042,846 Examiner Tse Chen Applicant(s)/Patent Under Reexamination HAIMOVSKY ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Ā	US-2002/0087854 A1	07-2002	Haigh et al.	713/1
	В	US-6,757,759 B1	06-2004	Jones et al.	710/100
	С	US-5,539,890 A	07-1996	Rahman et al.	710/262
	D	US-5,535,417	07-1996	Baji et al.	710/22
	Ε	US-5,872,967	02-1999	DeRoo et al.	713/2
	F	US-5,867,713	02-1999	Shrader et al.	717/176
	Ġ	US-5,842,011	11-1998	Basu, Tushar K.	713/2
	Н	US-5,764,593	06-1998	Turpin et al.	713/2
	1	US-5,867,713	02-1999	Shrader et al.	717/176
	J	US-5,991,817	11-1999	Rowett et al.	709/250
	К	US-6,401,183	06-2002	Rafizadeh, Schumann	711/173
	L	US-			
	Ń	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	σ					
	R	•				
	S					
	T					·

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	Ú	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.